TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC174F,TC74VHC174FN,TC74VHC174FT

Hex D-Type Flip Flop with Clear

The TC74VHC174 is an advanced high speed CMOS HEX D-TYPE FLIP FLOP fabricated with silicon gate C^2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

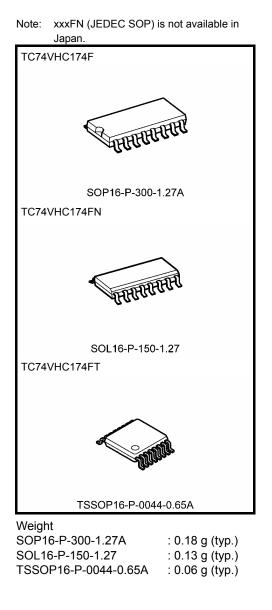
Information signals applied to D inputs are transferred to the Q output on the positive going edge of the clock pulse.

When the $\overline{\text{CLR}}$ input is held low, the Q output are in the low logic level independent of the other inputs.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

Features

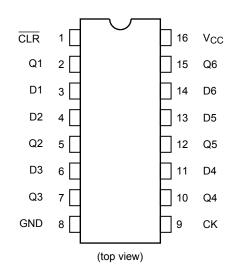
- High speed: $f_{max} = 150 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A \text{ (max)}$ at $Ta = 25^{\circ}C$
- High noise immunity: $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = 2 to 5.5 V
- Low noise: $V_{OLP} = 0.8 V (max)$
- Pin and function compatible with 74ALS174



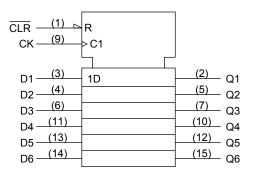
TC74VHC174F/FN/FT

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Pin Assignment



IEC Logic Symbol

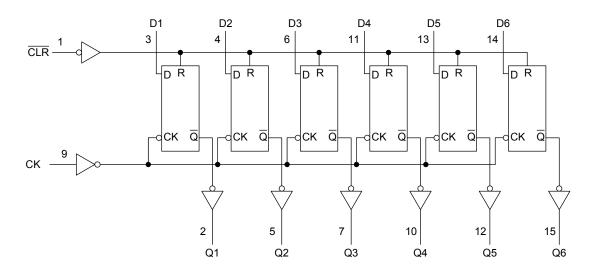


Truth Table

	Inputs	_	Output	Function		
CLR	D	СК	Q	FUNCTION		
L	Х	Х	L	Clear		
Н	L		L	_		
Н	Н		Н	_		
Н	Х		Qn	No Change		

X: Don't care

System Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5 to 7.0	V
DC input voltage	V _{IN}	-0.5 to 7.0	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	IIК	-20	mA
Output diode current	I _{ОК}	±20	mA
DC output current	IOUT	±25	mA
DC V _{CC} /ground current	Icc	±50	mA
Power dissipation	PD	180	mW
Storage temperature	T _{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0 to 5.5	V	
Input voltage	V _{IN}	0 to 5.5	V	
Output voltage	V _{OUT}	0 to V _{CC}	V	
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 100 (V _{CC} = 3.3 ± 0.3 V)	n o\/	
input rise and rail time	uluv	0 to 20 (V _{CC} = 5 \pm 0.5 V)	ns/V	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics

Characteristics	Symbol				1	「a = 25°(2	Ta = −40 to 85°C		Unit
Characteriotice	Cymbol			V _{CC} (V)	Min	Тур.	Max	Min	Max	
High-level input voltage	VIH	_			1.50 V _{CC} × 0.7		_	1.50 V _{CC} × 0.7	_	V
Low-level input voltage	VIL	_		2.0 3.0 to 5.5	_	_	0.50 V _{CC} × 0.3	_	0.50 V _{CC} × 0.3	V
High-level output voltage	Voн	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -50 μA I _{OH} = -4 mA	2.0 3.0 4.5 3.0	1.9 2.9 4.4 2.58	2.0 3.0 4.5		1.9 2.9 4.4 2.48		V
			$I_{OH} = -4 \text{ mA}$ $I_{OH} = -8 \text{ mA}$	3.0 4.5	2.56 3.94	_	_	3.80	_	
Low-level output voltage	V _{OL}	V _{IN} = V _{IH} or V _{IL}	l _{OL} = 50 μΑ	2.0 3.0 4.5		0.0 0.0 0.0	0.1 0.1 0.1		0.1 0.1 0.1	V
			I _{OL} = 4 mA I _{OL} = 8 mA	3.0 4.5		_	0.36 0.36	_	0.44 0.44	
Input leakage current	I _{IN}	V _{IN} = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μA
Quiescent supply current	ICC	V _{IN} = V _C	_C or GND	5.5	_	_	4.0	_	40.0	μA

Timing Requirements (input: tr = tf = 3 ns)

Characteristics	Symbol	Test Condition	Test Condition			Ta = -40 to 85°C	Unit
			V _{CC} (V)	Тур.	Limit	Limit	
Minimum pulse width	t _{w (L)}		3.3 ± 0.3	_	5.0	5.0	
(CK)	t _{w (H)}	—	5.0 ± 0.5	—	5.0	5.0	ns
Minimum pulse width	4		3.3 ± 0.3	_	5.0	5.0	20
(CLR)	t _{w (L)}	_	5.0 ± 0.5	—	5.0	5.0	ns
Minimum aat un tima	ts	_	3.3 ± 0.3	_	5.0	6.0	20
Minimum set-up time			5.0 ± 0.5	—	4.5	4.5	ns
Minimum hold time			3.3 ± 0.3	_	0.0	0.0	20
Minimum hold time t _h	۱h	_	5.0 ± 0.5	—	0.5	0.5	ns
Minimum removal time			3.3 ± 0.3	_	3.0	3.0	20
(CLR)	t _{rem}		5.0 ± 0.5	—	2.5	2.5	ns

AC Characteristics (input: tr = tf = 3 ns)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
	,		$V_{CC}(V)$	C _L (pF)	Min	Тур.	Max	Min	Max	
			3.3 ± 0.3	15	_	7.2	11.0	1.0	13.0	ns
Propagation delay time	t _{pLH}			50		9.7	14.5	1.0	16.5	
(CK-Q)	t _{pHL}	_	5.0 ± 0.5	15		4.9	7.2	1.0	8.5	
、 <i>,</i>			5.0 ± 0.5	50		6.4	9.2	1.0	10.5	
			3.3 ± 0.3	15		7.4	11.4	1.0	13.5	- ns
Propagation delay time (CLR -Q)	tpHL	_		50		9.9	14.9	1.0	17.0	
			5.0 ± 0.5	15		5.1	7.6	1.0	9.0	
`				50	_	6.6	9.6	1.0	11.0	
	f _{max}	_	3.3 ± 0.3	15	95	150	_	80	_	- MHz
Maximum clock				50	55	85	_	50	_	
frequency			5.0 ± 0.5	15	130	175	_	110	_	
				50	90	120	_	80	_	
	t _{osLH}	(Note 1)	3.3 ± 0.3	50	_	_	1.5	_	1.5	ns
Output to output skew	t _{osHL}		5.5 ± 0.5	50	-		1.0	-	1.0	115
Input capacitance	C _{IN}		_		_	4	10		10	pF
Power dissipation capacitance	C _{PD}			(Note 2)	_	29	_	_	_	pF

Note 1: Parameter guaranteed by design.

 $t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/6 (per F/F)$

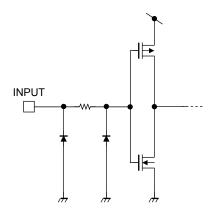
And the total C_{PD} when n pcs. of flip flop operate can be gained by the following equation:

C_{PD} (total) = 19 + 10·n

Noise Characteristics (input: tr = tf = 3 ns)

Characteristics	Symbol	Test Condition	-	Ta = 25°C		Unit
Characteristics	Symbol		$V_{CC}(V)$	Тур.	Max	Unit
Quiet output maximum dynamic V_{OL}	V _{OLP}	C _L = 50 pF	5.0	0.4	0.8	V
Quiet output minimum dynamic V_{OL}	V _{OLV}	C _L = 50 pF	5.0	-0.4	-0.8	V
Minimum high level dynamic input voltage	VIHD	C _L = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage	V _{ILD}	C _L = 50 pF	5.0	-	1.5	V

Input Equivalent Circuit

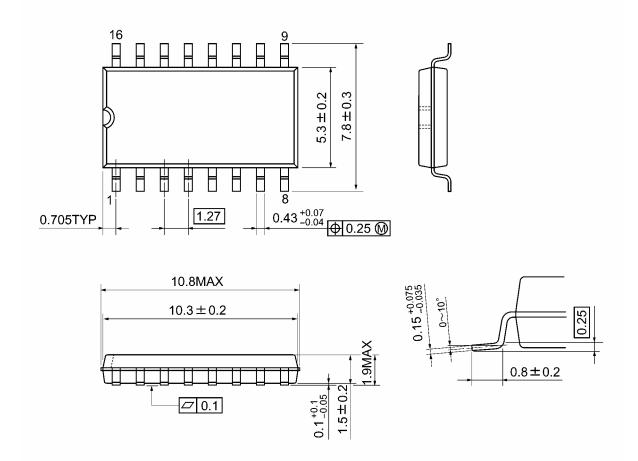




Package Dimensions

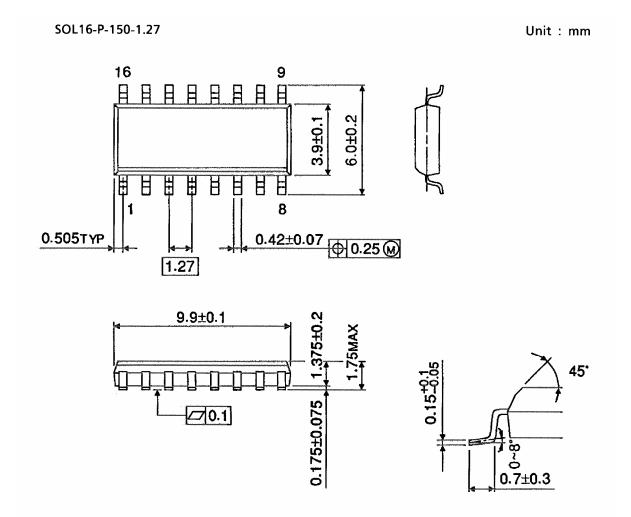
SOP16-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

Package Dimensions (Note)



Note: This package is not available in Japan.

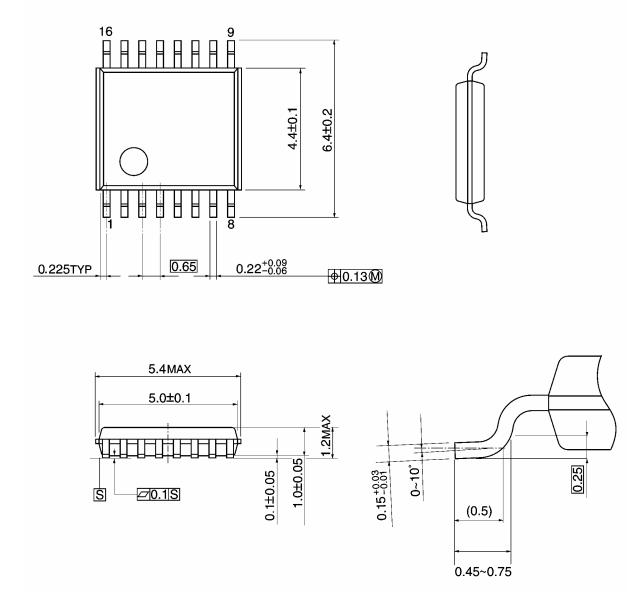
Weight: 0.13 g (typ.)

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Package Dimensions

TSSOP16-P-0044-0.65A

Unit: mm



Weight: 0.06 g (typ.)

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20070701-EN GENERAL

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